## Notice of References Cited Application/Control No. 10/808,341 Examiner Woo H. Choi Applicant(s)/Patent Under Reexamination YUN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0007636 A1	01-2003	Alves et al.	380/37
*	В	US-2003/0220562 A1	11-2003	Sasaki et al.	600/425
*	C	US-2003/0046513 A1	03-2003	Furuta et al.	712/15
*	D	US-6,738,891 B2	05-2004	Fujii et al.	712/16
*	E	US-6,622,233 B1	09-2003	Gilson, Kent L.	712/11
*	F	US-2004/0054870 A1	03-2004	Kirsch, Graham	712/011
*	G	US-6,426,754 B1	07-2002	Kyo, Sholin	345/556
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.